

Infrared Emitting Diodes(GaAlAs)

KODENSHI

CL - 209

The CL - 209 is a high - power GaAlAs IRED mounted in a TO - 46 metal stem with clear epoxy encapsulation, providing wide beam angle.

FEATURES

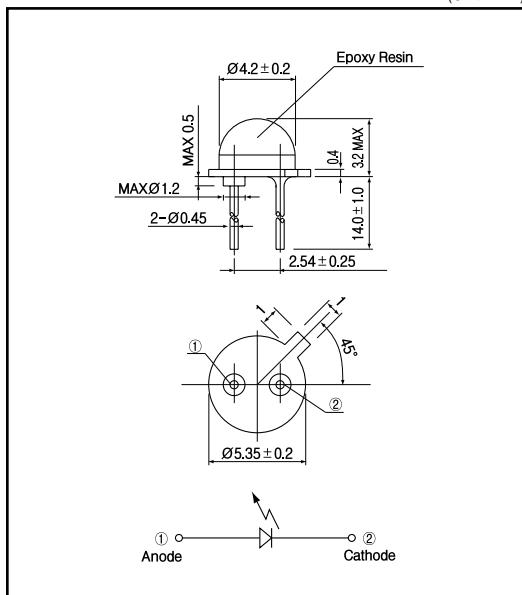
- High output power
- Wide beam angle $\pm 85\text{deg}$.
- TO - 46 epoxy potting type

APPLICATIONS

- Optical switches
- Transportation sensors

DIMENSIONS

(Unit : mm)

**MAXIMUM RATINGS**

(Ta=25)

Item	Symbol	Rating	Unit
Reverse voltage	V _R	5	V
Forward current	I _F	80	mA
Power dissipation	P _D	130	mW
Pulse forward current ^{*1}	I _{FP}	0.8	A
Operating temp.	T _{opr.}	- 20 + 80	
Storage temp.	T _{stg.}	- 20 + 80	
Soldering temp. ^{*2}	T _{sol.}	240	

*1. pulse width : tw 100 μ sec, period : T=10msec.

*2. For MAX.5 seconds at the position of 2 mm from the package

ELECTRO-OPTICAL CHARACTERISTICS

(Ta=25)

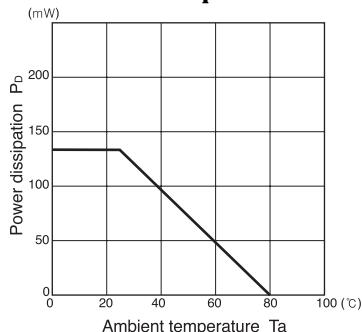
Item	Symbol	Conditions	Min.	Typ.	Max.	Unit.
Forward voltage	V _F	I _F =20mA		1.3	1.6	V
Reverse current	I _R	V _R =5V			10	μ A
Peak emission wavelength ^{*3}	λ	I _F =50mA		880		nm
Spectral bandwidth		I _F =50mA		70		nm
Radiant intensity	P _O	I _F =20mA		30		mV
Half angle				± 85		deg.

*3. Measured by tester of KODENSHI CORP.

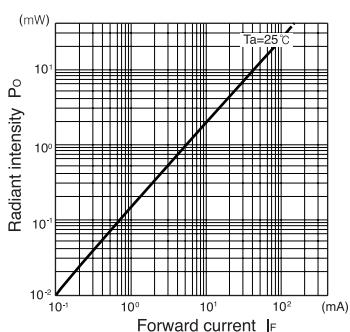
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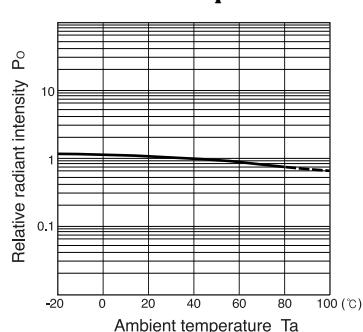
**Power dissipation Vs.
Ambient temperature**



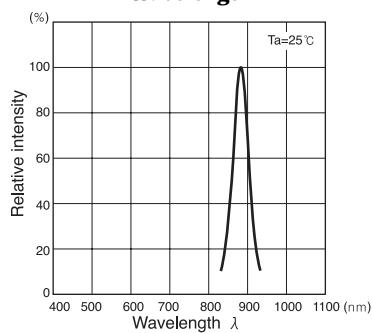
**Radiant intensity Vs.
Forward current**



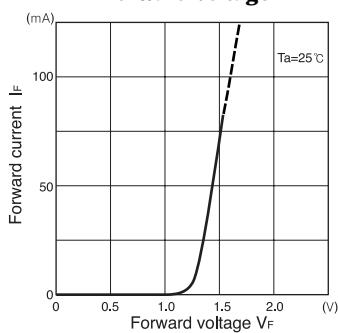
**Relative radiant intensity Vs.
Ambient temperature**



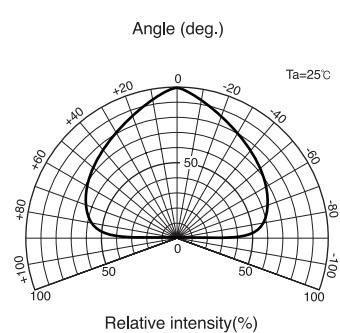
**Relative intensity Vs.
Wavelength**



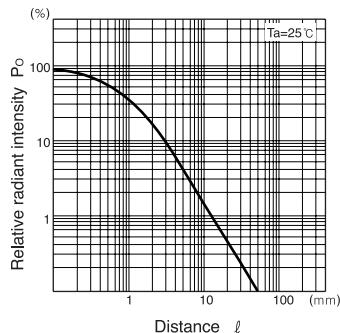
**Forward current Vs.
Forward voltage**



Radiant Pattern



**Relative radiant intensity Vs.
Distance**



Relative radiant intensity Vs.
Distance test method

